#### SILICON (Si) POWER MOSFET ▲ CED3425



CET MOS

# **CED3425**

# -30V ▲ 37mΩ ▲ -20A ▲ Si MOSFET

SILICON Si MOSFET ▲ THT type P-channel enhancement mode UL94V-0 rated flame retardant epoxy TO251 (E-PAK) package Super high dense cell density for extremely low R<sub>DS(ON)</sub> High power and current handling capability







#### **MAXIMUM RATINGS**

Parameter ( $T_c$ = 25°C, unless otherwise noted)	Characteristics	
Drain-Source Voltage	V <sub>DS</sub>	-30V
Gate-Source Voltage	V <sub>GS</sub>	±20V
Continuous Drain Current	I <sub>D</sub>	-20A
Pulsed Drain Current Note 1	I <sub>DM</sub>	-80A
Maximum Power Dissipation at T <sub>c</sub> = 25°C	PD	31W
Power Dissipation Derating above 25°C	ΔΡ <sub>D</sub>	0.25W/°C
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55°C to +150°C

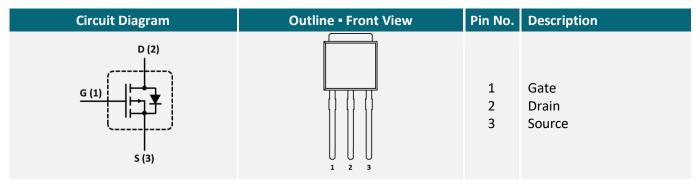
#### THERMAL CHARACTERISTICS

Parameter	Symbol	Limit
Thermal Resistance, Junction-to-Case	R <sub>TH_JC</sub>	3.9°C/W
Thermal Resistance, Junction-to-Ambient Note 2	R <sub>TH_JA</sub>	50°C/W

#### **APPLICATIONS**

DC/DC	DC	Load	Power	USB
Converter	Fan	Switches	Banks	Storage
			4	Y

#### **PIN DESCRIPTION**





# **ELECTRICAL CHARACTERISTICS** A T<sub>c</sub> = 25°C, unless otherwise noted

Item	Condition	Symbol	Min.	Тур.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = -250 \mu A$	BV <sub>DSS</sub>	-30			V
Zero Gate Voltage Drain Current	$V_{DS}$ = -30V, $V_{GS}$ = 0V	I <sub>DSS</sub>			-1	μΑ
Gate Body Leakage Current, Forward	$V_{GS} = 20V, V_{DS} = 0V$	I <sub>GSSF</sub>			100	nA
Gate Body Leakage Current, Reverse	$V_{GS}$ = -20V, $V_{DS}$ = 0V	I <sub>GSSR</sub>			-100	nA
On Characteristics Note 4						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	V <sub>GS(th)</sub>	-1		-3	V
Static Drain-Source On-Resistance	$V_{GS} = -10V$ , $I_{D} = -5.3A$	R <sub>DS(ON)</sub>		37	45	mΩ
Static Drain-Source On-Resistance	$V_{GS} = -4.5V$ , $I_D = -4.2A$	R <sub>DS(ON)</sub>		62	80	mΩ
Dynamic Characteristics Note 4						
Input Capacitance	$V_{DS}$ = -15V, $V_{GS}$ = 0V, f = 1MHz	C <sub>ISS</sub>		600		pF
Output Capacitance	$V_{DS}$ = -15V, $V_{GS}$ = 0V, f = 1MHz	Coss		100		pF
Reverse Transfer Capacitance	$V_{DS}$ = -15V, $V_{GS}$ = 0V, f = 1MHz	C <sub>RSS</sub>		65		pF
Switching Characteristics Note 4						
Turn-On Delay Time	$V_{\text{DD}}$ = -15V, $V_{\text{GS}}$ = -10V, $I_{\text{D}}$ = -1A, $R_{\text{G(ext)}}$ = 6 $\Omega$	t <sub>D(ON)</sub>		12		ns
Turn-On Rise Time	$V_{\text{DD}}$ = -15V, $V_{\text{GS}}$ = -10V, $I_{\text{D}}$ = -1A, $R_{\text{G(ext)}}$ = 6 $\Omega$	t <sub>R</sub>		4		ns
Turn-Off Delay Time	$V_{\text{DD}}$ = -15V, $V_{\text{GS}}$ = -10V, $I_{\text{D}}$ = -1A, $R_{\text{G(ext)}}$ = 6 $\Omega$	t <sub>D(OFF)</sub>		41		ns
Turn-Off Fall Time	$V_{\text{DD}}$ = -15V, $V_{\text{GS}}$ = -10V, $I_{\text{D}}$ = -1A, $R_{\text{G(ext)}}$ = 6 $\Omega$	t <sub>F</sub>		13		ns
Total Gate Charge	$V_{DS} = -15V, V_{GS} = -10V, I_D = -10A$	Q <sub>G</sub>		9.8		nC
Gate Source Charge	$V_{DS} = -15V, V_{GS} = -10V, I_D = -10A$	Q <sub>GS</sub>		1.5		nC
Gate Drain Charge	$V_{DS}$ = -15V, $V_{GS}$ = -10V, $I_{D}$ = -10A	$\mathbf{Q}_{GD}$		2.3		nC
Drain-Source Diode Characteristics a	nd Maximum Ratings					
Drain-Source Diode Forward Current <sup>Note 2</sup>		I <sub>S</sub>			-20	А
Drain-Source Diode Forward Voltage <sup>Note 3</sup>	$V_{GS} = 0V, I_{S} = -5.3A$	$V_{\text{SD}}$			-1.3	V

#### Notes

1: Repetitive Rating: Pulse width limited by maximum junction temperature

2: Surface Mounted on FR4 Board,  $t \le 10$  sec.

3: Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

4: Guaranteed by design, not subject to production testing.



## **REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE**

Fig. 1 • Output Characteristics Fig. 2 • Transfer Characteristics 25 30 -V<sub>GS</sub>=10,9,8,5V T\_=125°C -55°C 20 24 Ib, Drain Current (A) Ib, Drain Current (A) -V<sub>GS</sub>=4V 15 18 10 12 6 5 25 -V<sub>GS</sub>=3V 0 0 2 6 2 4 6 8 10 0 4 8 10 0 -VDS, Drain-to-Source Voltage (V) -VGS, Gate-to-Source Voltage (V) Fig. 3 • Capacitance Fig. 4 • On-Resistance Variation with Temperature 720 2.2 I<sub>D</sub>=-5.3A RDS(ON), On-Resistance(Ohms) Ciss V<sub>GS</sub>=-10V 600 1.9 RDS(ON), Normalized C, Capacitance (pF) 480 1.6 360 1.3 240 1.0 Coss 0.7 120 Crss 0 0.4 3 6 9 12 0 15 -100 -50 0 50 100 150 200 -VDS, Drain-to-Source Voltage (V) TJ, Junction Temperature(°C) Fig. 6 - Body Diode Forward Voltage Variation Fig. 5 • Gate Threshold Variation with Temperature with Source Current 1.3 V<sub>DS</sub>=V<sub>GS</sub> V<sub>GS</sub>=0V Gate-Source Threshold Voltage -ls, Source-drain current (A) I<sub>D</sub>=-250μΑ 1.2 10<sup>1</sup> VTH, Normalized 1.1 1.0 0.9 10<sup>0</sup> 0.8 0.7 0.6 10<sup>-1</sup> -25 0 25 50 75 -50 100 125 150 0.4 0.6 0.8 1.0 1.2 1.4 TJ, Junction Temperature(°C) -Vsp, Body Diode Forward Voltage (V)



#### **REFERENCE DATA A TYPICAL DEVICE PERFORMANCE**

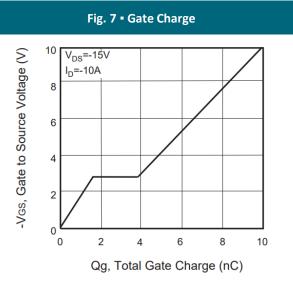
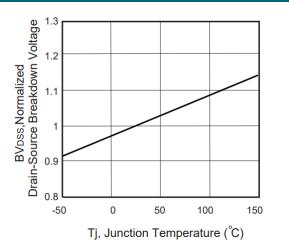
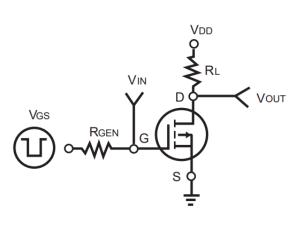


Fig. 9 - Breakdown Voltage Variation vs. Temperature







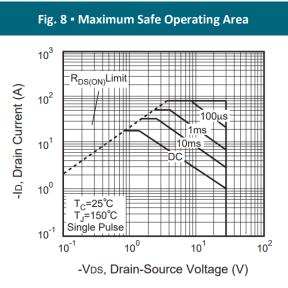
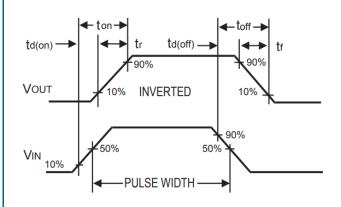


Fig. 11 • Switching Waveforms



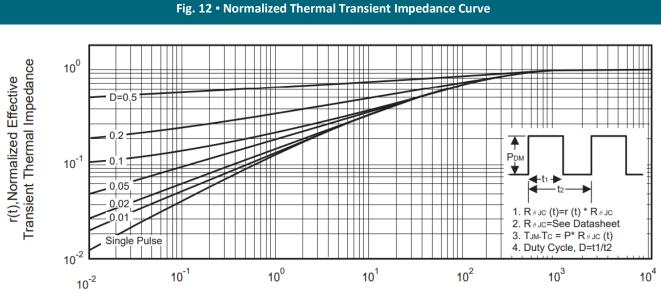
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## **REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE**

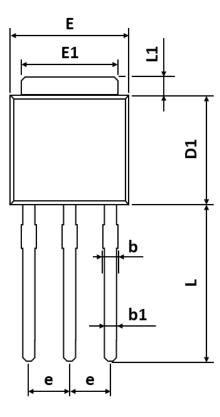


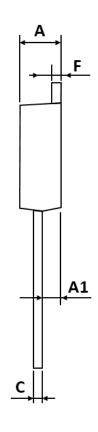
Square Wave Pulse Duration (msec)

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#### **PACKAGE OUTLINE**





Sym	Millimeters (Min.)	Millimeters (Typ.)	Millimeters (Max.)
А	2.180	-	2.400
A1	0.860	-	1.500
b	0.700	-	0.960
b1	0.700	-	0.860
С	0.400	-	0.610
D1	5.400	-	6.630
E	6.050	-	7.010
E1	4.950	-	5.460
e	1.980	-	2.590
F	0.400	-	0.890
L	8.500	-	9.650
L1	0.500	-	1.800

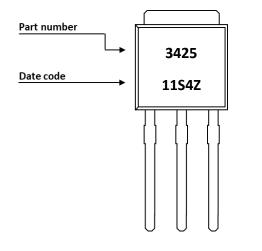
#### **ORDERING INFORMATION**

Part Number	Package	Packing	Tube Qty.	Inner Box Qty.	Outer Box Qty.
CED3425	TO251 (E-PAK)	Tube	80pcs	4,000pcs	16,000pcs

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#### **PART MARKING**



#### DATE CODE

Example: 11S4Z



| Product Type Z: Pb-free G: Green Product

	Coding list for "Day"								
<b>1</b>	<b>2</b>	<b>3</b>	<b>4</b>	<b>5</b>	<b>6</b>	<b>7</b>	<b>8</b>	<b>9</b>	<b>A</b>
01	02	03	04	05	06	07	08	09	10
<b>B</b>	<b>C</b>	<b>D</b>	<b>E</b>	<b>F</b>	<b>G</b>	<b>H</b>	<b> </b>	<b>J</b>	<b>K</b>
11	12	13	14	15	16	17	18	19	20
<b>L</b>	<b>M</b>	<b>N</b>	<b>O</b>	<b>P</b>	<b>Q</b>	<b>R</b>	<b>S</b>	<b>T</b>	<b>U</b>
21	22	23	24	25	26	27	28	29	30
<b>V</b> 31									

Coding list for "Month"

<b>1</b> Jan	<b>2</b> Feb		<b>5</b> May	
<b>7</b> Jul	<b>8</b> Aug		<b>B</b> Nov	<b>C</b> Dec

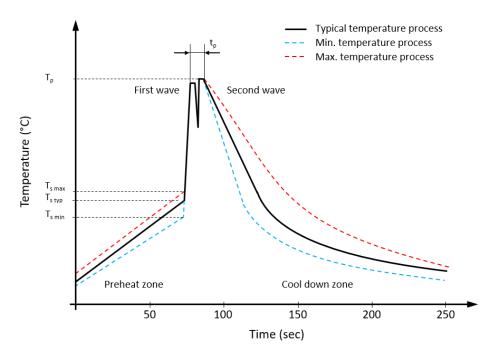
Coding list for "Year"







## **RECOMMENDED WAVE SOLDERING PROFILE A THT PACKAGE**



#### Classification wave soldering profile ▲ Refer to EN 61760-1: 2006

Profile Features		Value 🛦 Sn-Pb Assembly	Value 🔺 Pb-free Assembly
Preheat temperature min.	$T_{s min}$	100 °C	100 °C
Preheat temperature typical	T <sub>s typ</sub>	120 °C	120 °C
Preheat temperature max.	$T_{s max}$	130 °C	130 °C
Preheat time $t_s$ from $T_{s min}$ to $T_{s max}$	ts	70 seconds	70 seconds
Peak temperature	Tp	235 °C to 260 °C	245 °C to 260 °C
Time of actual peak temperature	t <sub>p</sub>	Max. 10 seconds Max. 5 second each wave	Max. 10 seconds Max. 5 second each wave
Ramp-down date min.		~ 2 °C/second	~ 2 °C/second
Ramp-down rate typical		~ 3.5 °C/second	~ 3.5 °C/second
Ramp-down rate max.		~ 5 °C/second	~ 5 °C/second
Time 25°C to 25°C		4 minutes	4 minutes



# **REVISION TABLE**

Revision	Date	Status	Notes
001	30/09/2022	Initial release	Initial publication

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